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Adsorption and surface reaction of bis-diethylaminosilane as a Si precursor on an OH-terminated Si (001) surface

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Abstract
The adsorption and the surface reaction of bis-diethylaminosilane (SiH₂[N(C₂H₅)₂]₂, BDEAS) as a Si precursor on an OH-terminated Si (001) surface were investigated to understand the initial reaction mechanism of the atomic layer deposition (ALD) process using density functional theory. The bond dissociation energies between two atoms in BDEAS increased in the order of Si–H, Si–N, and the rest of the bonds. Therefore, the relatively weak Si–H and Si–N bonds were considered for bond breaking during the surface reaction. Optimum locations of BDEAS for the Si–H and Si–N bond breaking were determined on the surface, and adsorption energies of 0.43 and 0.60 eV, respectively, were obtained. The Si–H bond dissociation energy of the adsorbed BDEAS on the surface did not decrease, so that a high reaction energy barrier of 1.60 eV was required. On the other hand, the Si–N bond dissociation energy did decrease, so that a relatively low reaction energy barrier of 0.52 eV was required. When the surface reaction energy barrier was higher than the adsorption energy, BDEAS would be desorbed from the surface instead of being reacted. Therefore, the Si–N bond breaking would be dominantly involved during the surface reaction, and the result is in good agreement with the experimental data in the literature.

Keywords: Bond dissociation energy; Adsorption; Surface reaction; Bis-diethylaminosilane; Atomic layer
deposition; Density functional theory
1. Introduction

Since the size of semiconductor devices has diminished and the ratio between the height and width of features has increased continuously, it has become more difficult to deposit uniform and conformal thin-films. Atomic layer deposition (ALD), a deposition technique based on sequential and self-limiting surface reactions, has become more prevalent in terms of depositing thin-films in the semiconductor fabrication processes due to its excellent uniformity and conformality [1,2]. To achieve uniform and conformal thin-films using the ALD technique, precursors must possess several important properties: They should not react by themselves when they are contained in a canister; they should not decompose in the gas phase when they are delivered into a reaction chamber; they should react with the surface when they are adsorbed on it; and excess precursors should not react with the surface after the surface is saturated by the precursors. Additionally, the reaction energy barrier between the precursor and surface should be lower than its adsorption energy, so that the precursor can react with the surface without being desorbed.

Among many Si precursors, bis-diethylaminosilane (SiH$_2$(N(C$_2$H$_5$)$_2$)$_2$, BDEAS) has been used for the deposition of SiO$_2$ thin-films through the ALD technique, as it can be deposited in a wide temperature range of 100–400 °C with a high deposition rate, as well as having good thermal stability [3]. Katamreddy et al. reported that BDEAS was a suitable Si precursor for HfSiO$_x$ because it suppressed the structural change of the thin-films from the amorphous to the crystalline phase [4]. Moreover, Won et al. reported that SiO$_2$ thin-film showed an excellent breakdown field because it had very low carbon content, and did not exhibit oxygen deficiency or nonbridging oxygens [5]. Recently, Baek et al. theoretically studied the adsorption energy of BDEAS and its reaction energy barrier on an OH-terminated Si (001) surface using density functional theory (DFT), without considering the van der Waals interaction [6]. They obtained an adsorption energy of 0.20 eV and a reaction energy barrier of 0.62 eV. Since the adsorption energy is less than the reaction energy barrier, the precursor will be desorbed rather than being reacted. Therefore, the theoretical result could not explain the easily deposited initial experimental ALD process [3-5].

In this study, the adsorption and surface reaction of BDEAS with –OH on a Si (001) surface were investigated to understand the initial reaction mechanism of the ALD process using DFT with consideration of the van der Waals interaction. Based on the bond dissociation energies between two atoms in BDEAS, two weak bonds were considered for bond breaking during the reaction with the
surface. The accurately obtained adsorption energies and reaction energy barriers were well interrelated, thereby elucidating the initial experimental ALD process.

2. Calculation details

All DFT calculations were performed using the Vienna *ab-initio* simulation package (VASP) code [7-10]. Electron wave functions were described using the projector augmented wave (PAW) method of Blöchl [11] implemented in the VASP code by Kresse and Joubert [12]. The exchange correlation energy was described by the generalized gradient approximation (GGA) of Perdew, Burke, and Ernzerhof (PBE) [13]. All calculations considered van der Waals interactions based on Grimme’s DFT-D2 approach in PAW; the van der Waals interactions were described via a simple pair-wise force field, which was optimized for several popular DFT functionals, such as PBE and B3LYP [14]. Since the geometric configuration was not well optimized with DFT-D2, all geometric configurations were first optimized by DFT. The cutoff energy of 500 eV and 2×2×1 k-points mesh with zero shift for a slab structure including a 2 nm vacuum layer were used to generate the plane wave basis set with the Monkhorst-Pack grid method [15]. Partial wave occupancies were calculated with the Gaussian smearing method, and its factor was 0.05 eV. Electronic and geometry optimizations were converged when the total energy difference between successive calculation steps was less than $10^{-3}$ and $10^{-2}$ eV, respectively. All atoms were allowed to relax until the force on each atom was below 0.2 eV/nm.

Using these computational settings, the Si unit cell was optimized and a lattice parameter of 5.411 Å was obtained. This value was in good agreement with the experimental and computational lattice parameters (5.416 and 5.41 Å) [16]. A Si (001) surface with a 4×4 surface size and four Si layers was constructed using the optimized Si unit cells. Two neighboring Si atoms of the surface formed the Si dimer, which buckled in a zigzag pattern below the order–disorder transition temperature to reduce the surface energy [17,18]. OHs were attached to the top-layer Si atoms to form an OH-terminated Si (001) surface [19], and H atoms were attached to the bottom-layer Si atoms to remove their dangling bonds. Bond lengths between two atoms in the optimized Si (001) surface were in good agreement with previous surface calculation, as shown in Table 1 [20]. One bottom Si layer was fixed among four Si layers with H atoms underneath, and the three top Si layers with OHs on top were allowed to relax. BDEAS was optimized to calculate the bond dissociation energies between two atoms of BDEAS in a 3×3×3 nm
vacuum region. For bond dissociation energy calculation between the two atoms in BDEAS, the molecule was divided into two groups by breaking the bond between the two atoms while maintaining the molecular structure of the two groups, in the same way as that of the molecule. The optimized BDEAS was introduced to the surface, and its adsorption and reaction energy barrier calculations were carried out using the climbing nudged elastic band (CI-NEB) tool implemented in the VASP code. Six images, including the initial and final configurations, were used for the CI-NEB calculations. Atoms in the relaxed layers and BDEAS were allowed to relax during the energy barrier calculations. The electron density image was drawn by the visualization for electronic and structural analysis (VESTA) tool [21]. An isosurface level is the amount of electron charge per \( a_0^3 \) (\( a_0 = \) Bohr radius), and the value is 0.15 in this study.

3. Results and discussion

Fig. 1(a) shows the optimized BDEAS with the electron density distribution. BDEAS consists of one Si atom, two H atoms, and two amino groups including two N atoms and four ethyls (\( \text{C}_2\text{H}_5 \)'s). The Si atom is positively charged, whereas the N and H atoms are negatively charged in BDEAS due to the relatively strong electronegativity of the N and H atoms (3.04, 2.20) compared to the Si atom (1.90) [22]. Fig. 1(b) shows a fully OH-terminated Si (001) surface with the electron density distribution. The H atoms of OH’s are positively charged, whereas the O atoms are negatively charged due to the relatively strong electronegativity of the O atom (3.44) compared to the H atom (2.20) [22]. From these electron distributions, the Si and H atoms or Si and N atoms of BDEAS could be adsorbed on the O and H atoms of –OH on the surface, respectively. Bond lengths and bond dissociation energies between two atoms in BDEAS are shown in Table II. The bond lengths between the two atoms of the optimized BDEAS were in good agreement with the common bond lengths [23]. Si–H and Si–N bonds were weak among the bonds in BDEAS, and their bond dissociation energies were 4.98 and 5.00 eV with the bond lengths of 1.49 and 1.72 Å, respectively. Therefore, Si–H or Si–N bond is expected to be broken when BDEAS reacts with –OH on the surface. We tried several different configurations of BDEAS to find optimum adsorption sites on the fully OH-terminated Si (001) surface for its reaction with consideration of Si–H or Si–N bond breaking.

Fig. 2 shows an optimum BDEAS adsorption (adsorption energy: 0.43 eV) on the surface with
consideration of Si–H bond breaking, and the energy variation for its surface reaction. The adsorption energy was 0.10 eV without the van der Waals interaction. The relative energy is set to 0 eV as a reference when BDEAS is located at a distance of 10 Å from the surface. The positively charged Si atom of the adsorbed BDEAS was located on the negatively charged O atom of –OH at a Si\_BDEAS···O\_OH distance of 3.12 Å. The negatively charged H atom of the adsorbed BDEAS was located on the positively charged H atom of –OH at a H\_BDEAS···H\_OH distance of 2.21 Å. The chemical reaction formula of BDEAS with –OH on the surface is as follows:

\[
-\text{OH} + \text{SiH}_2[\text{N(C}_2\text{H}_5)_2]_2 \rightarrow -\text{O}–\text{SiH}[\text{N(C}_2\text{H}_5)_2]_2 + \text{H}_2.
\]

The adsorbed BDEAS reacted with –OH to produce a silylhydride group (–SiH[\text{N(C}_2\text{H}_5)_2]) and H\_2 with its reaction energy barrier of 1.60 eV. The Si atom of the silylhydride group was bonded to the O atom of –OH with a bond length of 1.66 Å, and the generated H\_2 as a by-product was located near the silylhydride group at a distance of 3.65 Å. The energy was decreased to -1.38 from -0.43 eV after the surface reaction. The adsorbed BDEAS for Si–H bond breaking would rather be desorbed from the surface, because the reaction energy barrier was higher than the adsorption energy.

Fig. 3 shows an optimum BDEAS adsorption (adsorption energy: 0.60 eV) on the surface with consideration of Si–N bond breaking, and the energy variation for its surface reaction. The adsorption energy was 0.20 eV without the van der Waals interaction. The positively charged Si atom from BDEAS was located on the negatively charged O atom of –OH at a Si\_BDEAS···O\_OH distance of 3.60 Å. The negatively charged N atom of BDEAS was located on the positively charged H atom of –OH at a N\_BDEAS···H\_OH distance of 2.52 Å. The reaction formula is given below:

\[
-\text{OH} + \text{SiH}_2[\text{N(C}_2\text{H}_5)_2]_2 \rightarrow -\text{O}–\text{SiH}_2[\text{N(C}_2\text{H}_5)_2] + \text{NH(C}_2\text{H}_5)_2.
\]

The adsorbed BDEAS reacted with –OH to produce a silylene group (–SiH\_2[\text{N(C}_2\text{H}_5)_2]) and diethylamine (\text{NH(C}_2\text{H}_5)_2, DEA), with a reaction energy barrier of 0.52 eV. The Si atom of the silylene group was bonded to the O atom of –OH with a bond length of 1.67 Å, and the DEA generated as a by-product was located near the silylene group at a distance of 2.91 Å. Experimentally, DEA is measured by quadrupole
mass spectrometry (QMS) during the first half cycle of ALD [24]. The energy was decreased to -0.95 from -0.60 eV after the surface reaction. The adsorbed BDEAS for Si–N bond breaking could react with the surface because the adsorption energy was high enough for BDEAS to stay on the surface during the reaction.

Although the bond dissociation energy of the Si–H bond is smaller than that of the Si–N bond in BDEAS, as shown in Table I, its surface reaction with –OH is dominated by Si–N bond breaking. To understand this reaction mechanism, the variation of bond lengths and bond dissociation energies of the Si–H and Si–N bonds in BDEAS and the O–H bond in –OH were calculated before and after the BDEAS adsorption on the surface, as shown in Table II. When BDEAS was in vacuum, the bond dissociation energies of the Si–H, Si–N, and O–H bonds were 4.98, 5.00, and 5.58 eV with the bond lengths of 1.49, 1.72, and 0.97 Å, respectively. When BDEAS was adsorbed on the surface, as shown in Fig. 2, the bond dissociation energies of the Si–H and O–H bonds were nearly unchanged, at 4.85 and 5.45 eV, with the same bond lengths of 1.49 and 1.72 Å. On the other hand, when BDEAS was adsorbed on the surface, as shown in Fig. 3, the bond dissociation energies of the Si–N and O–H bonds significantly decreased from 5.00 to 4.42 and from 5.58 to 5.01 eV, respectively. The bond lengths of the Si–N and O–H bonds also increased from 1.72 and 0.97 to 1.74 and 0.99 Å, respectively. In summary, when BDEAS was adsorbed on the surface with a certain configuration, its adsorption energy was high, sometimes causing order reversal of the bond dissociation energies, for example, in the Si–N and Si–H bonds at the adsorption configuration with consideration of Si–N bond breaking. Since strong adsorption could also weaken the neighboring bonds that were to be broken for surface reaction, the surface reaction energy barrier would be affected.

4. Conclusions

The adsorption and surface reaction of BDEAS as a Si precursor on an OH-terminated Si (001) surface were investigated to understand the initial reaction mechanism of ALD process using DFT. The Si–H bond was weaker than the Si–N bond when BDEAS was in vacuum. When BDEAS was adsorbed on the surface with consideration of Si–H bond breaking, its adsorption energy and reaction energy barrier were 0.43 and 1.60 eV, respectively. The adsorbed BDEAS was desorbed from the surface rather than reacting with the surface because its reaction energy barrier was higher than its adsorption energy. When BDEAS
was adsorbed on the surface with consideration of Si–N bond breaking, its adsorption energy and reaction energy barrier were 0.60 and 0.52 eV, respectively. The adsorbed BDEAS would react with –OH on the surface because its reaction energy barrier was lower than its adsorption energy. Therefore, the adsorption configuration of BDEAS on the surface could determine the dominant bond breaking during the surface reaction by affecting its adsorption energy and the bond dissociation energies of the neighboring bonds. This result was in good agreement with the experimental data in the literature.

Acknowledgements

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References


Table captions

Table I. Bond lengths between two atoms in a fully OH-terminated Si (001) surface.

<table>
<thead>
<tr>
<th>Bond type</th>
<th>Bond length [Å]</th>
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<td>O–H</td>
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<td>0.97</td>
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<tr>
<td>Si–O</td>
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<td>Si dimer</td>
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Table II. Bond lengths and bond dissociation energies between two atoms in BDEAS.

<table>
<thead>
<tr>
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<th>Bond dissociation energy [eV]</th>
<th>In this study</th>
<th>Ref 23</th>
<th></th>
</tr>
</thead>
<tbody>
<tr>
<td>Si–H</td>
<td>1.49</td>
<td>4.98</td>
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</tr>
<tr>
<td>Si–N</td>
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<tr>
<td>N–C</td>
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<td>5.45</td>
<td>1.47</td>
<td></td>
<td></td>
</tr>
<tr>
<td>C–C</td>
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<td>5.56</td>
<td>1.54</td>
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<td></td>
</tr>
<tr>
<td>C–H1*</td>
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<td>1.09</td>
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<tr>
<td>C–H2**</td>
<td>1.10</td>
<td>6.41</td>
<td>1.09</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

* C–H1: A C atom is bonded to an N atom.
** C–H2: A C atom is bonded to a C atom.

Table III. Bond lengths and bond dissociation energies of the Si–H and Si–N bonds in BDEAS, and the O–H bond in –OH before and after the adsorption of BDEAS on a fully OH-terminated Si (001) surface.

<table>
<thead>
<tr>
<th>Bond type</th>
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<th>After adsorption</th>
<th>Adsorption with consideration of</th>
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<td>Si–H in BDEAS</td>
<td>1.49</td>
<td>1.49</td>
<td>4.98</td>
</tr>
<tr>
<td>O–H in –OH</td>
<td>0.97</td>
<td>0.97</td>
<td>5.58</td>
</tr>
<tr>
<td>Si–N in BDEAS</td>
<td>1.72</td>
<td>1.74</td>
<td>5.00</td>
</tr>
<tr>
<td>O–H in –OH</td>
<td>0.97</td>
<td>0.99</td>
<td>5.58</td>
</tr>
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</table>
Figure captions

Fig. 1. Perspective views of (a) the optimized BDEAS and (b) a fully OH-terminated Si (001) surface with the electron density distribution. The Si atom is positively charged and the N and H atoms are negatively charged in BDEAS. The O atom is negatively charged and the H atom is positively charged in –OH on the Si (100) surface.

Fig. 2. Energy variation for the BDEAS reaction with –OH on the Si (001) surface to produce a BDEAS group and H₂. Perspective views are shown along the [100] direction. “TS” in this figure indicates a transition state.

Fig. 3. Energy variation for the BDEAS reaction with –OH on the Si (001) surface to produce a DEAS group and DEA. Perspective views are shown along the [100] direction. “TS” in this figure indicates a transition state.
Highlights

- Initial reaction mechanism of bis-diethylaminosilane as a Si precursor on an OH-terminated Si (001) surface was investigated to understand the initial atomic layer deposition process.

- The adsorption configuration of the precursor on the surface affects its adsorption energy and bond dissociation energies of the neighboring bonds, resulting in the decrease of the reaction energy barrier.

- The adsorption energy of the precursor on the surface should be higher than the reaction energy barrier for the reaction.
Graphical abstract

The adsorption energy and reaction energy barrier between BDEAS and OH-terminated Si (001) surface were 0.60 eV and 0.52 eV, respectively. When the surface reaction energy barrier was lower than the adsorption energy, BDEAS would react with the surface instead of being desorbed.